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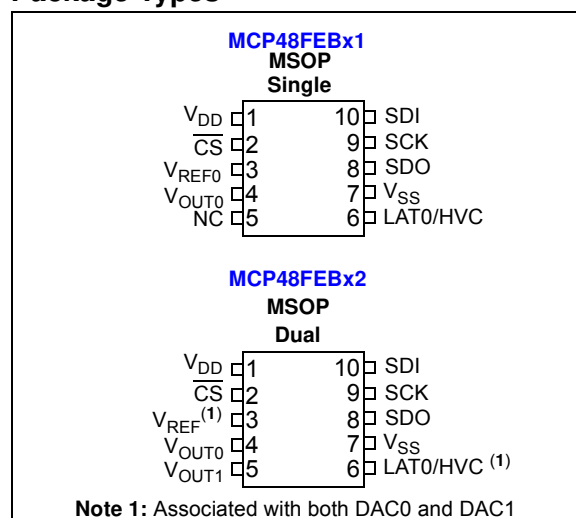


8-/10-/12-Bit Single/Dual Voltage Output Nonvolatile Digital-to-Analog Converters with SPI Interface

Features

- Operating Voltage Range:
 - 2.7V to 5.5V - full specifications
 - 1.8V to 2.7V - reduced device specifications
- Output Voltage Resolutions:
 - 8-bit: **MCP48FEB0X** (256 Steps)
 - 10-bit: **MCP48FEB1X** (1024 Steps)
 - 12-bit: **MCP48FEB2X** (4096 Steps)
- Rail-to-Rail Output
- Fast Settling Time of 7.8 μ s (typical)
- DAC Voltage Reference Source Options:
 - Device V_{DD}
 - External V_{REF} pin (buffered or unbuffered)
 - Internal Band Gap (1.22V typical)
- Output Gain Options:
 - Unity (1x)
 - 2x
- Nonvolatile Memory (EEPROM):
 - User-programmed Power-on Reset (POR)/Brown-out Reset (BOR) output setting, recall and device configuration bits
 - Auto Recall of Saved DAC register setting
 - Auto Recall of Saved Device Configuration (Voltage Reference, Gain, Power-Down)
- Power-on/Brown-out Reset Protection
- Power-Down Modes:
 - Disconnects output buffer (High Impedance)
 - Selection of V_{OUT} pull-down resistors (100 k Ω or 1 k Ω)
- Low Power Consumption:
 - Normal operation: <180 μ A (Single), 380 μ A (Dual)
 - Power-down operation: 650 nA typical
 - EEPROM write cycle (1.9 mA maximum)
- SPI Interface:
 - Supports '00' and '11' modes
 - Up to 20 MHz writes and 10 MHz reads
 - Input buffers support interfacing to low-voltage digital devices
- Package Types: 10-lead MSOP
- Extended Temperature Range: -40°C to +125°C

Package Types



General Description

The MCP48FEBXX are Single- and Dual-channel 8-bit, 10-bit, and 12-bit buffered voltage output Digital-to-Analog Converters (DAC) with nonvolatile memory and an SPI serial interface.

The V_{REF} pin, the device V_{DD} or the internal band gap voltage can be selected as the DAC's reference voltage. When V_{DD} is selected, V_{DD} is connected internally to the DAC reference circuit. When the V_{REF} pin is used, the user can select the output buffer's gain to be 1 or 2. When the gain is 2, the V_{REF} pin voltage should be limited to a maximum of $V_{DD}/2$.

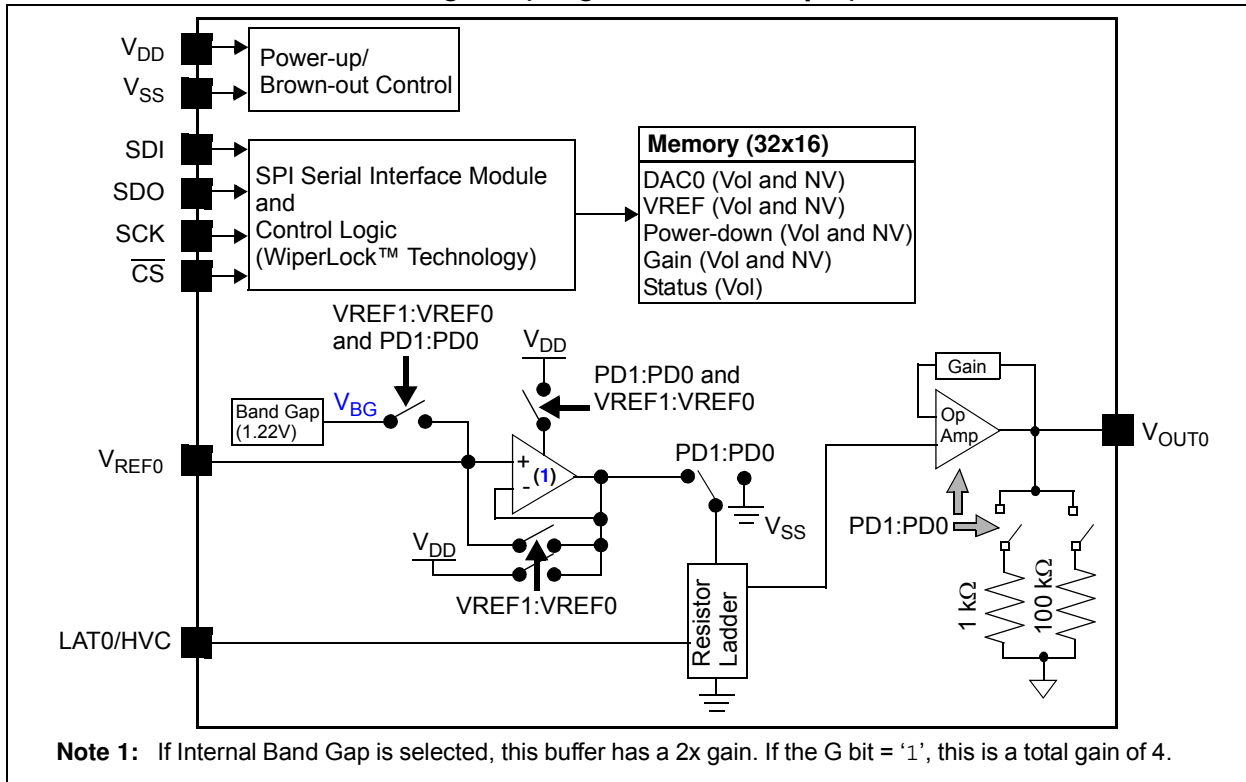
These devices have an SPI-compatible serial interface. Write commands are supported up to 20 MHz while read commands are supported up to 10 MHz.

Applications

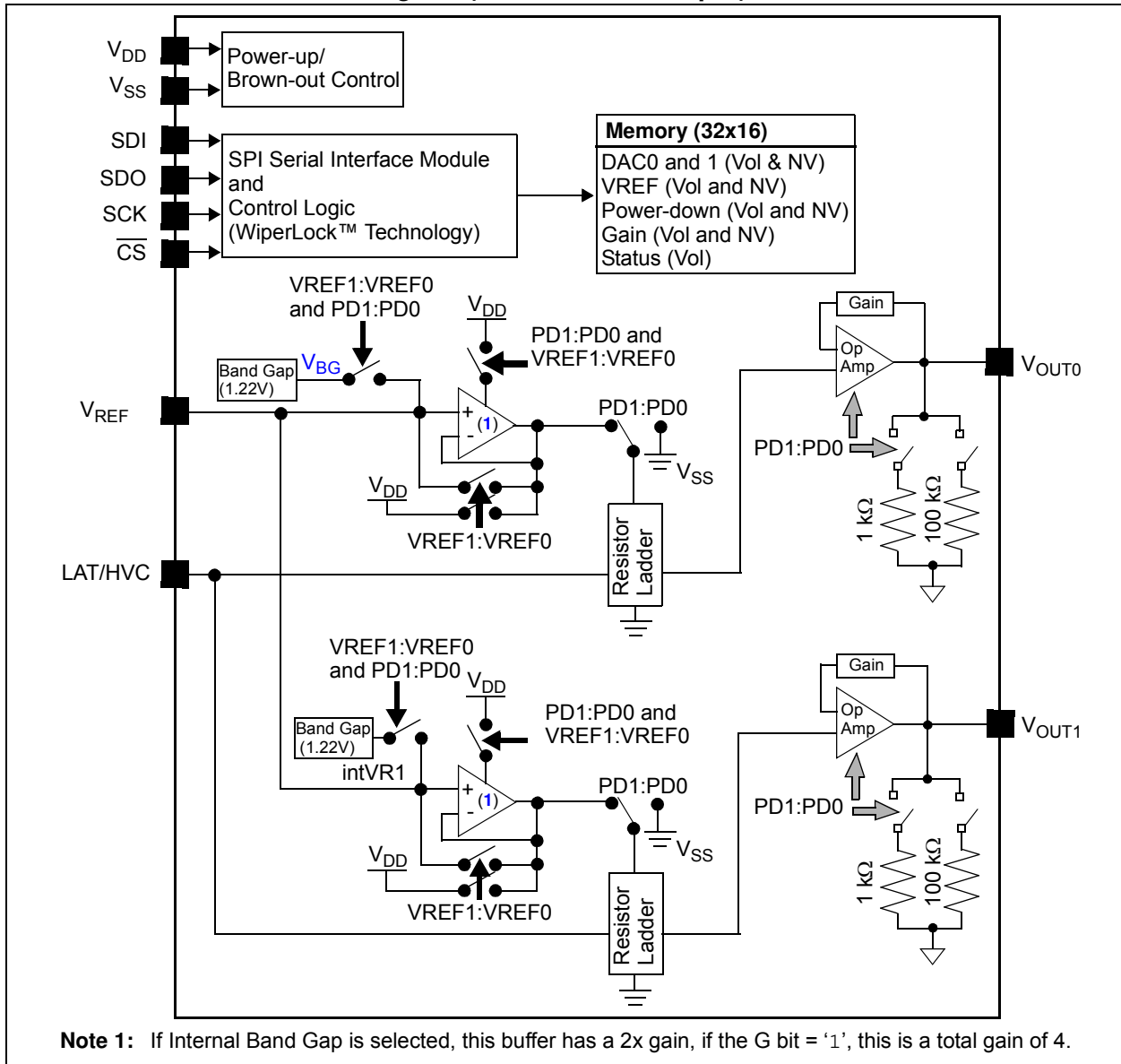
- Set Point or Offset Trimming
- Sensor Calibration
- Low-Power Portable Instrumentation
- PC Peripherals
- Data Acquisition Systems
- Motor Control

MCP48FEBXX

MCP48FEBX1 Device Block Diagram (Single-Channel Output)



MCP48FEBX2 Device Block Diagram (Dual-Channel Output)



MCP48FEBXX

Device Features

Device	# of Channels	Resolution (bits)	Control Interface	DAC Output POR/BOR Setting ⁽¹⁾	# of VREF Inputs	Internal band gap ?	# of LAT Inputs	Memory	Specified Operating Range (V _{DD}) ⁽²⁾
MCP48FEB01	1	8	SPI	7Fh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP48FEB11	1	10	SPI	1FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP48FEB21	1	12	SPI	7FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP48FEB02	2	8	SPI	7Fh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP48FEB12	2	10	SPI	1FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP48FEB22	2	12	SPI	7FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FVB01	1	8	I ² C™	7Fh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FVB11	1	10	I ² C	1FFh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FVB21	1	12	I ² C	7FFh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FVB02	2	8	I ² C	7Fh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FVB12	2	10	I ² C	1FFh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FVB22	2	12	I ² C	7FFh	1	Yes	1	RAM	1.8V to 5.5V
MCP47FEB01	1	8	I ² C	7Fh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FEB11	1	10	I ² C	1FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FEB21	1	12	I ² C	7FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FEB02	2	8	I ² C	7Fh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FEB12	2	10	I ² C	1FFh	1	Yes	1	EEPROM	1.8V to 5.5V
MCP47FEB22	2	12	I ² C	7FFh	1	Yes	1	EEPROM	1.8V to 5.5V

Note 1: Factory Default value. The DAC output POR/BOR value can be modified via the nonvolatile DAC output register(s) (available only on nonvolatile devices (MCP4XFEBXX)).

2: Analog output performance specified from 2.7V to 5.5V.

1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (†)

Voltage on V_{DD} with respect to V_{SS}	-0.6V to +6.5V
Voltage on all pins with respect to V_{SS}	-0.6V to $V_{DD}+0.3V$
Input clamp current, I_{IK} ($V_I < 0$, $V_I > V_{DD}$, $V_I > V_{PP}$ on HV pins)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{DD}$).....	± 20 mA
Maximum current out of V_{SS} pin (Single).....	50 mA
(Dual).....	100 mA
Maximum current into V_{DD} pin (Single).....	50 mA
(Dual).....	100 mA
Maximum current sourced by the V_{OUT} pin	20 mA
Maximum current sunk by the V_{OUT} pin.....	20 mA
Maximum current sunk by the V_{REF} pin	125 μ A
Maximum input current source/sunk by SDI, SCK, and \overline{CS} pins	2 mA
Maximum output current sunk by SDO Output pin	25 mA
Total power dissipation ⁽¹⁾	400 mW
Package power dissipation ($T_A = +50^\circ\text{C}$, $T_J = +150^\circ\text{C}$)	
MSOP-10	490 mW
ESD protection on all pins	$\geq \pm 4$ kV (HBM)
.....	$\geq \pm 400$ V (MM)
.....	$\geq \pm 1.5$ kV (CDM)
Latch-Up (per JEDEC JESD78A) @ $+125^\circ\text{C}$	± 100 mA
Storage temperature	-65°C to $+150^\circ\text{C}$
Ambient temperature with power applied	-55°C to $+125^\circ\text{C}$
Soldering temperature of leads (10 seconds).....	$+300^\circ\text{C}$
Maximum Junction Temperature (T_J).....	$+150^\circ\text{C}$

† **Notice:** Stresses above those listed under “Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Note 1: Power dissipation is calculated as follows:

$$P_{DIS} = V_{DD} \times \{I_{DD} - \sum I_{OH}\} + \sum \{(V_{DD} - V_{OH}) \times I_{OH}\} + \sum (V_{OL} \times I_{OL})$$

MCP48FEBXX

DC CHARACTERISTICS

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Supply Voltage	V_{DD}	2.7	—	5.5	V	
		1.8	—	2.7	V	DAC operation (reduced analog specifications) and Serial Interface
V_{DD} Voltage (rising) to ensure device Power-on Reset	$V_{POR/BOR}$	—	—	1.7	V	RAM retention voltage (V_{RAM}) < V_{POR} V_{DD} voltages greater than $V_{POR/BOR}$ limit Ensure that device is out of reset.
V_{DD} Rise Rate to ensure Power-on Reset	V_{DDRR}	(Note 3)			V/ms	
High-Voltage Commands Voltage Range (HVC pin)	V_{HV}	V_{SS}	—	12.5	V	The HVC pin will be at one of three input levels (V_{IL} , V_{IH} or V_{IHH}) ⁽¹⁾
High-Voltage Input Entry Voltage	V_{IHEN}	9.0	—	—	V	Threshold for Entry into WiperLock Technology
High-Voltage Input Exit Voltage	V_{IHHEX}	—	—	$V_{DD} + 0.8\text{V}$	V	(Note 2)
Power-on Reset to Output-Driven Delay	T_{PORD}	—	25	50	μs	V_{DD} rising, $V_{DD} > V_{POR}$

Note 1 This parameter is ensured by design.

Note 2 This parameter is ensured by characterization.

Note 3 POR/BOR voltage trip point is not slope dependent. Hysteresis implemented with time delay.

DC CHARACTERISTICS (CONTINUED)

DC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +2.7\text{V}$ to 5.5V , $V_{REF} = +2.048\text{V}$ to V_{DD} , $V_{SS} = 0\text{V}$ $G_X = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to V_{SS} , $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions		
Supply Current	I_{DD}	—	—	320	μA	Single	1MHz ⁽²⁾	Serial Interface Active (Not High-Voltage Command) $VRxB:VRxA = '01'$ ⁽⁶⁾ V_{OUT} is unloaded, $V_{DD} = 5.5\text{V}$ Volatile DAC Register = 000h
		—	—	910	μA		10MHz ⁽²⁾	
		—	—	1.7	mA		20MHz	
		—	—	510	μA	Dual	1MHz ⁽²⁾	
		—	—	1.1	mA		10MHz ⁽²⁾	
		—	—	1.85	mA		20MHz	
		—	—	250	μA	Single	1MHz ⁽²⁾	Serial Interface Active (Not High-Voltage Command) $VRxB:VRxA = '10'$ ⁽⁴⁾ V_{OUT} is unloaded. $V_{REF} = V_{DD} = 5.5\text{V}$ Volatile DAC Register = 000h
		—	—	840	μA		10MHz ⁽²⁾	
		—	—	1.65	mA		20MHz ⁽²⁾	
		—	—	380	μA	Dual	1MHz ⁽²⁾	
		—	—	970	μA		10MHz ⁽²⁾	
		—	—	1.75	mA		20MHz ⁽²⁾	
		—	—	180	μA	Single	Serial Interface Inactive ⁽²⁾ (Not High-Voltage Command) $VRxB:VRxA = '00'$ $SCK = SDI = V_{SS}$ V_{OUT} is unloaded. Volatile DAC Register = 000h	
		—	—	380	μA		Dual	
		—	—	180	μA	Single	Serial Interface Inactive ⁽²⁾ (Not High-Voltage Command) $VRxB:VRxA = '11'$, $V_{REF} = V_{DD}$ $SCK = SDI = V_{SS}$ V_{OUT} is unloaded. Volatile DAC Register = 000h	
		—	—	380	μA		Dual	
—	—	1.9	mA	EE Write Current $V_{REF} = V_{DD} = 5.5\text{V}$ (After write, Serial Interface is Inactive.) Write all 0's to non-volatile DAC 0 (address 10h). V_{OUT} pins are unloaded.				
—	145	180	μA	Single	HVC = 12.5V (High-Voltage Command) Serial Interface Inactive			
—	260	400	μA		Dual	$V_{REF} = V_{DD} = 5.5\text{V}$, $LAT/HVC = V_{IH}$ DAC registers = 000h V_{OUT} pins are unloaded.		
Power-Down Current	I_{DDP}	—	0.65	3.8	μA	$PDxB:PDxA = '01'$ ⁽⁵⁾ , V_{OUT} not connected		

Note 2 This parameter is ensured by characterization.

Note 4 Supply current is independent of current through the resistor ladder in mode $VRxB:VRxA = '10'$.

Note 5 The $PDxB:PDxA = '01'$, $'10'$, and $'11'$ configurations should have the same current.

Note 6 By design, this is the worst-case current mode.

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DC CHARACTERISTICS (CONTINUED)

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions	
Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +2.7\text{V to } 5.5\text{V}$, $V_{REF} = +2.048\text{V to } V_{DD}$, $V_{SS} = 0\text{V}$ $G_X = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to V_{SS} , $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.							
Resistor Ladder Resistance	R_L	100	140	180	$\text{k}\Omega$	$1.8\text{V} \leq V_{DD} \leq 5.5\text{V}$ $V_{REF} \geq 1.0\text{V}$ ⁽⁷⁾	
Resolution (# of Resistors and # of Taps) (see B.1 "Resolution")	N	256			Taps	8-bit	No Missing Codes
		1024			Taps	10-bit	No Missing Codes
		4096			Taps	12-bit	No Missing Codes
Nominal V_{OUT} Match ⁽¹¹⁾	$\frac{ V_{OUT} - V_{OUTMEAN} }{V_{OUTMEAN}}$	—	0.5	1.0	%	$2.7\text{V} \leq V_{DD} \leq 5.5\text{V}$ ⁽²⁾	
		—	—	1.2	%	1.8V ⁽²⁾	
V_{OUT} Tempco (see B.19 " V_{OUT} Temperature Coefficient")	$\Delta V_{OUT}/\Delta T$	—	15	—	ppm/ $^{\circ}\text{C}$	Code = Mid-scale (7Fh, 1FFh or 7FFh)	
V_{REF} pin Input Voltage Range	V_{REF}	V_{SS}	—	V_{DD}	V	$1.8\text{V} \leq V_{DD} \leq 5.5\text{V}$ ⁽¹⁾	

Note 1 This parameter is ensured by design.

Note 2 This parameter is ensured by characterization.

Note 7 Resistance is defined as the resistance between the V_{REF} pin (mode VRxB:VRxA = '10') to V_{SS} pin. For dual-channel devices (MCP48FEBX2), this is the effective resistance of the each resistor ladder. The resistance measurement is of the two resistor ladders measured in parallel.

Note 11 Variation of one output voltage to mean output voltage.

DC CHARACTERISTICS (CONTINUED)

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions		
Zero-Scale Error (see B.5 “Zero-Scale Error (E _{ZS})”) (Code = 000h)	E _{ZS}	—	—	0.75	LSb	8-bit	VRxB:VRxA = ‘11’, Gx = ‘0’ V _{REF} = V _{DD} , No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘00’, Gx = ‘0’ V _{DD} = 5.5V, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘10’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘11’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘01’, Gx = ‘0’, No Load	
		—	—	3	LSb	10-bit	VRxB:VRxA = ‘11’, Gx = ‘0’ V _{REF} = V _{DD} , No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘00’, Gx = ‘0’ V _{DD} = 5.5V, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘10’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘11’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘01’, Gx = ‘0’ No Load	
		—	—	12	LSb	12-bit	VRxB:VRxA = ‘11’, Gx = ‘0’ V _{REF} = V _{DD} , No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘00’, Gx = ‘0’ V _{DD} = 5.5V, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘10’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		V _{DD} = 1.8V, V _{REF} = 1.0V VRxB:VRxA = ‘11’, Gx = ‘0’, No Load	
		See Section 2.0 “Typical Performance Curves” (2)			LSb		VRxB:VRxA = ‘01’, Gx = ‘0’ No Load	
		Offset Error (see B.7 “Offset Error (E _{OS})”)	E _{OS}	-15	±1.5	+15	mV	VRxB:VRxA = ‘00’ Gx = ‘0’ No Load
		Offset Voltage Temperature Coefficient	V _{OSTC}	—	±10	—	µV/°C	

Note 2 This parameter is ensured by characterization.

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DC CHARACTERISTICS (CONTINUED)

DC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +2.7\text{V to } 5.5\text{V}$, $V_{REF} = +2.048\text{V to } V_{DD}$, $V_{SS} = 0\text{V}$ $G_x = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to GND, $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.				
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Full-Scale Error (see B.4 "Full-Scale Error (EFS)")	E _{FS}	—	—	4.5	LSb	8-bit Code = FFh, VRxB:VRxA = '11' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFh, VRxB:VRxA = '10' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFh, VRxB:VRxA = '01' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFh, VRxB:VRxA = '00' No Load
		—	—	18	LSb	10-bit Code = 3FFh, VRxB:VRxA = '11' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = 3FFh, VRxB:VRxA = '10' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = 3FFh, VRxB:VRxA = '01' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = 3FFh, VRxB:VRxA = '00' No Load
		—	—	70	LSb	12-bit Code = FFFh, VRxB:VRxA = '11' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFFh, VRxB:VRxA = '10' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFFh, VRxB:VRxA = '01' Gx = '0', V _{REF} = 2.048V, No Load
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Code = FFFh, VRxB:VRxA = '00' No Load

Note 2 This parameter is ensured by characterization.

DC CHARACTERISTICS (CONTINUED)

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions	
Gain Error (see B.9 "Gain Error (EG)") ⁽⁸⁾	E_G	-1.0	±0.1	+1.0	% of FSR	8-bit	Code = 250, No Load VRxB:VRxA = '00' Gx = '0'
		-1.0	±0.1	+1.0	% of FSR	10-bit	Code = 1000, No Load VRxB:VRxA = '00' Gx = '0'
		-1.0	±0.1	+1.0	% of FSR	12-bit	Code = 4000, No Load VRxB:VRxA = '00' Gx = '0'
Gain-Error Drift (see B.10 "Gain-Error Drift (EGD)")	$\Delta G/^\circ C$	—	-3	—	ppm/°C		

Note 2 This parameter is ensured by characterization.

Note 8 This gain error does not include offset error.

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DC CHARACTERISTICS (CONTINUED)

DC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +2.7\text{V}$ to 5.5V , $V_{REF} = +2.048\text{V}$ to V_{DD} , $V_{SS} = 0\text{V}$ $G_x = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to GND, $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.				
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Integral Nonlinearity (see B.11 "Integral Nonlinearity (INL)") ⁽¹⁰⁾	INL	-0.5	± 0.1	+0.5	LSb	8-bit VRxB:VRxA = '10' (codes: 6 to 250) $V_{DD} = V_{REF} = 5.5\text{V}$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$ $V_{REF} = 1.0\text{V}$
		-1.5	± 0.4	+1.5	LSb	10-bit VRxB:VRxA = '10' (codes: 25 to 1000) $V_{DD} = V_{REF} = 5.5\text{V}$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$ $V_{REF} = 1.0\text{V}$
		-6	± 1.5	+6	LSb	12-bit VRxB:VRxA = '10' (codes: 100 to 4000) $V_{DD} = V_{REF} = 5.5\text{V}$.
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$ $V_{REF} = 1.0\text{V}$

Note 2 This parameter is ensured by characterization.

Note 10 Code range dependent on resolution: 8-bit, codes 6 to 250; 10-bit, codes 25 to 1000; 12-bit, codes 100 to 4000.

DC CHARACTERISTICS (CONTINUED)

DC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +2.7\text{V}$ to 5.5V , $V_{REF} = +2.048\text{V}$ to V_{DD} , $V_{SS} = 0\text{V}$ $G_x = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to GND, $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.				
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Differential Nonlinearity (see B.12 "Differential Nonlinearity (DNL)") ⁽¹⁰⁾	DNL	-0.25	± 0.0125	+0.25	LSb	8-bit VRxB:VRxA = '10' (codes: 6 to 250) $V_{DD} = V_{REF} = 5.5\text{V}$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$
		-0.5	± 0.05	+0.5	LSb	10-bit VRxB:VRxA = '10' (codes: 25 to 1000) $V_{DD} = V_{REF} = 5.5\text{V}$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$
		-1.0	± 0.2	+1.0	LSb	12-bit VRxB:VRxA = '10' (codes: 100 to 4000) $V_{DD} = V_{REF} = 5.5\text{V}$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '00', '01', '11'
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '01' $V_{DD} = 5.5\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	Char: VRxB:VRxA = '10', '11' $V_{REF} = 1.0\text{V}$, $G_x = '1'$
		See Section 2.0 "Typical Performance Curves" ⁽²⁾			LSb	$V_{DD} = 1.8\text{V}$

Note 2 This parameter is ensured by characterization.

Note 10 Code range dependent on resolution: 8-bit, codes 6 to 250; 10-bit, codes 25 to 1000; 12-bit, codes 100 to 4000.

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DC CHARACTERISTICS (CONTINUED)

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
-3 dB Bandwidth (see B.16 “-3 dB Bandwidth”)	BW	—	200	—	kHz	$V_{REF} = 2.048\text{V} \pm 0.1\text{V}$ $VRxB:VRxA = '10'$, $G_x = '0'$
		—	100	—	kHz	$V_{REF} = 2.048\text{V} \pm 0.1\text{V}$ $VRxB:VRxA = '10'$, $G_x = '1'$
Output Amplifier						
Minimum Output Voltage	$V_{OUT(MIN)}$	—	0.01	—	V	$1.8\text{V} \leq V_{DD} < 5.5\text{V}$ Output Amplifier's minimum drive
Maximum Output Voltage	$V_{OUT(MAX)}$	—	$V_{DD} - 0.04$	—	V	$1.8\text{V} \leq V_{DD} < 5.5\text{V}$ Output Amplifier's maximum drive
Phase Margin	PM	—	66	—	Degree ($^{\circ}$)	$C_L = 400\text{ pF}$ $R_L = \infty$
Slew Rate ⁽⁹⁾	SR	—	0.44	—	V/ μs	$R_L = 5\text{ k}\Omega$
Short-Circuit Current	I_{SC}	3	9	14	mA	DAC code = Full Scale
Internal Band Gap						
Band Gap Voltage	V_{BG}	1.18	1.22	1.26	V	
Band Gap Voltage Temperature Coefficient	V_{BGTC}	—	15	—	ppm/ $^{\circ}\text{C}$	
Operating Range (V_{DD})		2.0	—	5.5	V	V_{REF} pin voltage stable
		2.2	—	5.5	V	V_{OUT} output linear
External Reference (V_{REF})						
Input Range ⁽¹⁾	V_{REF}	V_{SS}	—	$V_{DD} - 0.04$	V	$VRxB:VRxA = '11'$ (Buffered mode)
		V_{DD}	—	V_{DD}	V	$VRxB:VRxA = '10'$ (Unbuffered mode)
Input Capacitance	C_{REF}	—	1	—	pF	$VRxB:VRxA = '10'$ (Unbuffered mode)
Total Harmonic Distortion ⁽¹⁾	THD	—	-64	—	dB	$V_{REF} = 2.048\text{V} \pm 0.1\text{V}$ $VRxB:VRxA = '10'$, $G_x = '0'$ Frequency = 1 kHz
Dynamic Performance						
Major Code Transition Glitch (see B.14 “Major-Code Transition Glitch”)		—	45	—	nV-s	1 LSB change around major carry (7FFh to 800h)
Digital Feedthrough (see B.15 “Digital Feed-through”)		—	<10	—	nV-s	

Note 1 This parameter is ensured by design.

Note 9 Within 1/2 LSB of final value when code changes from 1/4 to 3/4 of FSR. (Example: 400h to C00h in 12-bit device).

DC CHARACTERISTICS (CONTINUED)

Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Digital Inputs/Outputs (CS, SCK, SDI, SDO, LAT0/HVC)						
Schmitt Trigger High-Input Threshold	V_{IH}	$0.45 V_{DD}$	—	—	V	$2.7\text{V} \leq V_{DD} \leq 5.5\text{V}$
		$0.5 V_{DD}$	—	—	V	$1.8\text{V} \leq V_{DD} \leq 2.7\text{V}$
Schmitt Trigger Low-Input Threshold	V_{IL}	—	—	$0.2 V_{DD}$	V	
Hysteresis of Schmitt Trigger Inputs	V_{HYS}	—	$0.1 V_{DD}$	—	V	
Output Low Voltage	V_{OL}	V_{SS}	—	$0.3 V_{DD}$	V	$I_{OL} = 5\text{ mA}$, $V_{DD} = 5.5\text{V}$
		V_{SS}	—	$0.3 V_{DD}$	V	$I_{OL} = 1\text{ mA}$, $V_{DD} = 1.8\text{V}$
Output High Voltage	V_{OH}	$0.7V_{DD}$	—	V_{DD}	V	$I_{OH} = -2.5\text{ mA}$, $V_{DD} = 5.5\text{V}$
		$0.7V_{DD}$	—	V_{DD}	V	$I_{OH} = -1\text{ mA}$, $V_{DD} = 1.8\text{V}$
Input Leakage Current	I_{IL}	-1	—	1	μA	$V_{IN} = V_{DD}$ and $V_{IN} = V_{SS}$
Pin Capacitance	C_{IN} , C_{OUT}	—	10	—	pF	$f_C = 20\text{ MHz}$

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DC CHARACTERISTICS (CONTINUED)

Standard Operating Conditions (unless otherwise specified):							
Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended)							
Unless otherwise noted, all parameters apply across these specified operating ranges:							
$V_{DD} = +2.7\text{V to } 5.5\text{V}$, $V_{REF} = +2.048\text{V to } V_{DD}$, $V_{SS} = 0\text{V}$							
$G_x = '0'$, $R_L = 5\text{ k}\Omega$ from V_{OUT} to GND, $C_L = 100\text{ pF}$							
Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.							
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions	
RAM Value							
Value Range	N	0h	—	FFh	hex	8-bit	
		0h	—	3FFh	hex	10-bit	
		0h	—	FFFh	hex	12-bit	
DAC Register POR/BOR Value	N	See Table 4-2			hex	8-bit	
		See Table 4-2			hex	10-bit	
		See Table 4-2			hex	12-bit	
PDCON Initial Factory Setting		See Table 4-2			hex		
EEPROM							
Endurance	EN_{EE}	—	1M	—	Cycles	Note 1 , Note 2	
Data Retention	DR_{EE}	—	200	—	Years	At $+25^{\circ}\text{C}$ ⁽¹⁾ , ⁽²⁾	
EEPROM Range	N	0h	—	FFh	hex	8-bit	DACx Register(s)
		0h	—	3FFh	hex	10-bit	DACx Register(s)
		0h	—	FFFh	hex	12-bit	DACx Register(s)
Initial Factory Setting	N	See Table 4-2					
EEPROM Programming Write Cycle Time	t_{WC}	—	11	16	ms	$V_{DD} = +1.8\text{V to } 5.5\text{V}$	
Power Requirements							
Power Supply Sensitivity (B.17 “ Power-Supply Sensitivity (PSS) ”)	PSS	—	0.002	0.005	%/%	8-bit	Code = 7Fh
		—	0.002	0.005	%/%	10-bit	Code = 1FFh
		—	0.002	0.005	%/%	12-bit	Code = 7FFh

Note 1 This parameter is ensured by design.

Note 2 This parameter is ensured by characterization.

DC Notes:

1. This parameter is ensured by design.
2. This parameter is ensured by characterization.
3. POR/BOR voltage trip point is not slope dependent. Hysteresis implemented with time delay.
4. Supply current is independent of current through the resistor ladder in mode VRxB:VRxA = '10'.
5. The PDxB:PDxA = '01', '10', and '11' configurations should have the same current.
6. By design, this is the worst-case current mode.
7. Resistance is defined as the resistance between the V_{REF} pin (mode VRxB:VRxA = '10') to V_{SS} pin. For dual-channel devices (MCP48FEBX2), this is the effective resistance of the each resistor ladder. The resistance measurement is of the two resistor ladders measured in parallel.
8. This gain error does not include offset error.
9. Within 1/2 LSb of final value when code changes from 1/4 to 3/4 of FSR. (Example: 400h to C00h in 12-bit device).
10. Code range dependent on resolution: 8-bit, codes 6 to 250; 10-bit, codes 25 to 1000; 12-bit, codes 100 to 4000.
11. Variation of one output voltage to mean output voltage.

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1.1 Reset, Power-Down, and SPI Mode Timing Waveforms and Requirements

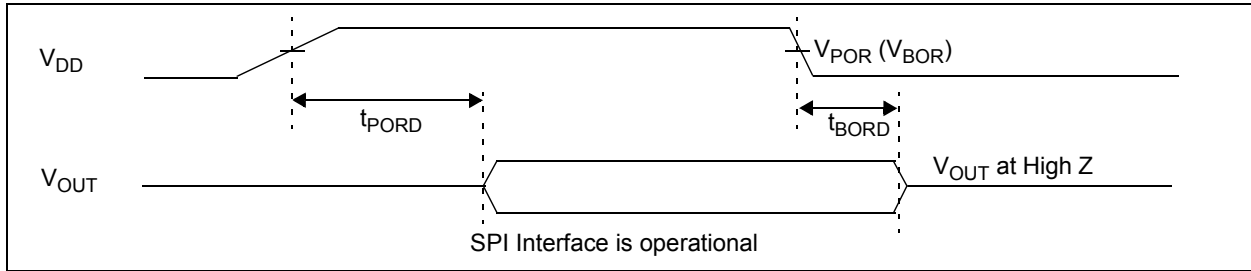


FIGURE 1-1: Power-on and Brown-out Reset Waveforms.

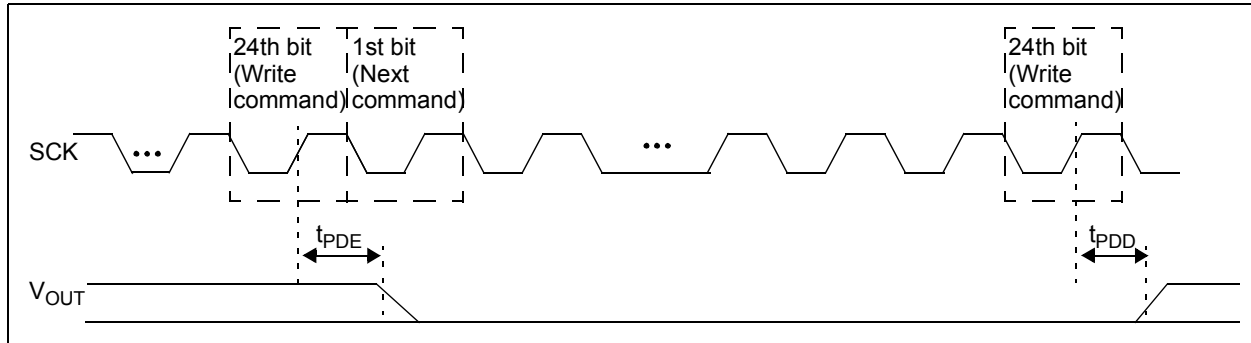


FIGURE 1-2: SPI Power-Down Command Waveforms.

TABLE 1-1: RESET AND POWER-DOWN TIMING

Timing Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +1.8\text{V to } 5.5\text{V}$, $V_{SS} = 0\text{V}$ $R_L = 5\text{ k}\Omega$ from V_{OUT} to V_{SS} , $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.				
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Power-on Reset Delay	t_{PORD}	—	60	—	μs	
Brown-out Reset Delay	t_{BORD}	—	45	—	μs	V_{DD} transitions from $V_{DD(MIN)} \rightarrow > V_{POR}$ V_{OUT} driven to V_{OUT} disabled
Power-Down Output Disable Time Delay	T_{PDD}	—	10.5	—	μs	$\text{PDxB:PDxA} = '11', '10', \text{ or } '01' \rightarrow '00'$ started from falling edge of the SCK at the end of the 24th clock cycle. Volatile DAC Register = FFh, $V_{OUT} = 10\text{ mV}$. V_{OUT} not connected.
Power-Down Output Enable Time Delay	T_{PDE}	—	1	—	μs	$\text{PDxB:PDxA} = '00' \rightarrow '11', '10', \text{ or } '01'$ started from falling edge of the SCK at the end of the 24th clock cycle. $V_{OUT} = V_{OUT} - 10\text{ mV}$. V_{OUT} not connected.

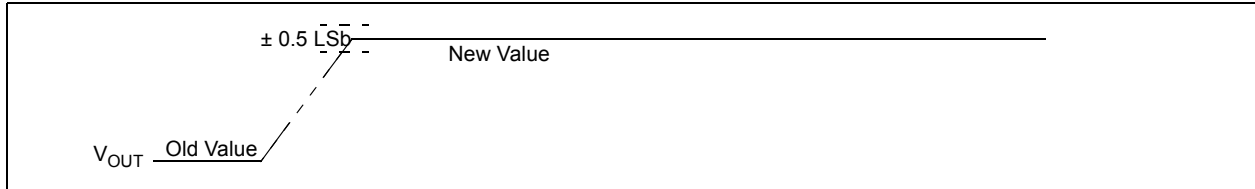


FIGURE 1-3: V_{OUT} Settling Time Waveform.

TABLE 1-2: V_{OUT} SETTling TIMING

Timing Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Unless otherwise noted, all parameters apply across these specified operating ranges: $V_{DD} = +1.8\text{V}$ to 5.5V , $V_{SS} = 0\text{V}$ $R_L = 5\text{ k}\Omega$ from V_{OUT} to V_{SS} , $C_L = 100\text{ pF}$ Typical specifications represent values for $V_{DD} = 5.5\text{V}$, $T_A = +25^{\circ}\text{C}$.					
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions	
V_{OUT} Settling Time ($\pm 0.5\text{LSb}$ error band, $C_L = 100\text{ pF}$) (see B.13 “Settling Time”)	t_s	—	7.8	—	μs	8-bit	Code = 40h \rightarrow C0h; C0h \rightarrow 40h ⁽³⁾
		—	7.8	—	μs	10-bit	Code = 100h \rightarrow 300h; 300h \rightarrow 100h ⁽³⁾
		—	7.8	—	μs	12-bit	Code = 400h \rightarrow C00h; C00h \rightarrow 400h ⁽³⁾

Note 3 Within 1/2 LSB of final value when code changes from 1/4 to 3/4 of FSR. (Example: 400h to C00h in 12-bit device).

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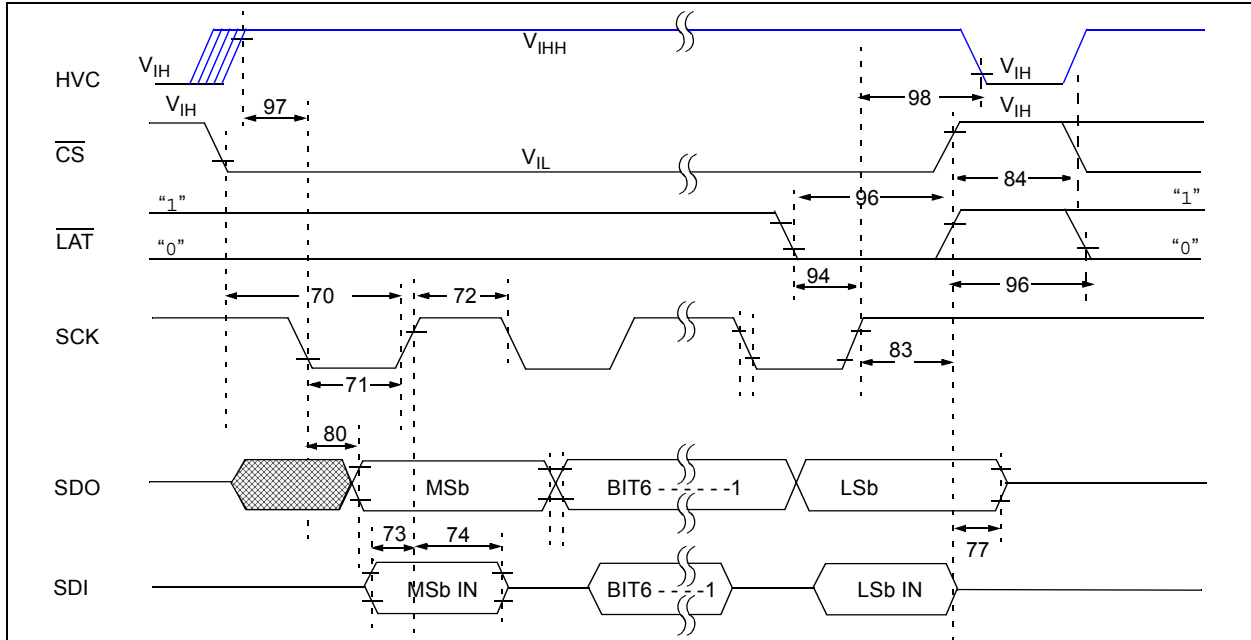


FIGURE 1-4: SPI Timing (Mode = 11) Waveforms.

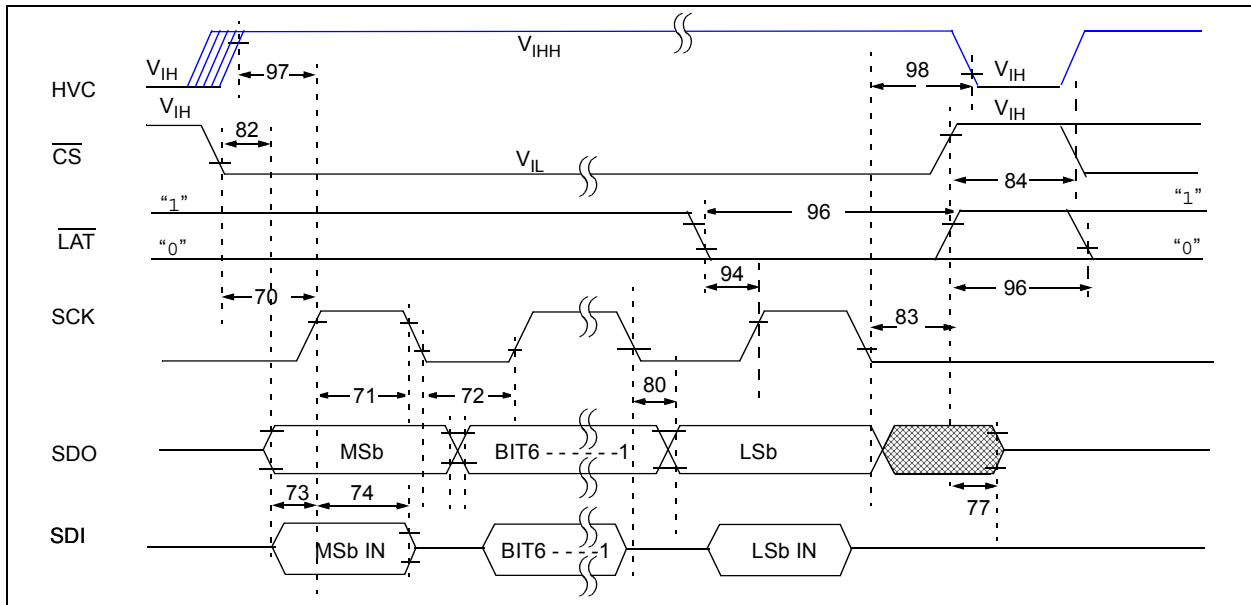


FIGURE 1-5: SPI Timing (Mode = 00) Waveforms.

TABLE 1-3: SPI REQUIREMENTS (MODE = 11)

SPI AC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Operating Voltage range is described in DC Characteristics .				
Param. No.	Symbol	Characteristic	Min.	Max.	Units	Conditions
	F_{SCK}	SCK input frequency	—	10	MHz	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$ (Read Command)
			—	20	MHz	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$ (All Other Commands)
			—	1	MHz	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
70	TcsA2sch	$\overline{\text{CS}}$ Active (V_{IL}) to command's 1st SCK \uparrow input	60	—	ns	
71	Tsch	SCK input high time	20	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			400	—	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
72	TscL	SCK input low time	20	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			400	—	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
73	TdiV2sch	Setup time of SDI input to SCK \uparrow edge	10	—	ns	
74	Tsch2diL	Hold time of SDI input from SCK \uparrow edge	20	—	ns	
77	TcsH2doZ	$\overline{\text{CS}}$ Inactive (V_{IH}) to SDO output hi-impedance	—	50	ns	Note 1
80	TscL2doV	SDO data output valid after SCK \downarrow edge	—	45	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			—	170	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
83	Tsch2csL	$\overline{\text{CS}}$ Inactive (V_{IH}) after SCK \uparrow edge	100	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			1	—	μs	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
84	TcsH	$\overline{\text{CS}}$ high time (V_{IH})	50	—	ns	
94	T_{LATSU}	$\overline{\text{LAT}} \downarrow$ to SCK \uparrow (write data 24th bit) setup time	20	—	ns	Write Data transferred ⁽⁴⁾
96	T_{LAT}	$\overline{\text{LAT}}$ high or low time	20	—	ns	
97	T_{HVCSU}	HVC \uparrow to SCK \downarrow (1st data bit) (HVC setup time)	0	—	ns	High-Voltage Commands ⁽¹⁾
98	T_{HVCHD}	SCK \uparrow (last bit of command (8th or 24th bit)) to HVC \downarrow (HVC hold time)	25	—	ns	High-Voltage Commands ⁽¹⁾

Note 1 This parameter is ensured by design.

Note 4 The transition of the LAT signal must occur 10 ns before the rising edge of the 24th SCK signal (Spec 94) or the current register data value may not be transferred to the output latch (VOUT) before the register is overwritten with the new value.

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TABLE 1-4: SPI REQUIREMENTS (MODE = 00)

SPI AC Characteristics		Standard Operating Conditions (unless otherwise specified): Operating Temperature: $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ (Extended) Operating Voltage range is described in DC Characteristics .				
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Conditions
	F_{SCK}	SCK input frequency	—	10	MHz	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$ (Read Command)
			—	20	MHz	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$ (All Other Commands)
			—	1	MHz	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
70	TcsA2sch	$\overline{\text{CS}}$ Active (V_{IL}) to SCK \uparrow input	60	—	ns	
71	Tsch	SCK input high time	20	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			400	—	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
72	TscL	SCK input low time	20	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			400	—	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
73	TdIV2sch	Setup time of SDI input to SCK \uparrow edge	10	—	ns	
74	Tsch2dIL	Hold time of SDI input from SCK \uparrow edge	20	—	ns	
77	TcsH2doZ	$\overline{\text{CS}}$ Inactive (V_{IH}) to SDO output hi-impedance	—	50	ns	Note 1
80	TscL2doV	SDO data output valid after SCK \downarrow edge	—	45	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			—	170	ns	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
82	TssL2doV	SDO data output valid after $\overline{\text{CS}}$ Active (V_{IL})	—	70	ns	
83	Tsch2csL	$\overline{\text{CS}}$ Inactive (V_{IH}) after SCK \downarrow edge	100	—	ns	$V_{\text{DD}} = 2.7\text{V to } 5.5\text{V}$
			1	—	μs	$V_{\text{DD}} = 1.8\text{V to } 2.7\text{V}$
84	TcsH	$\overline{\text{CS}}$ high time (V_{IH})	50	—	ns	
94	T _{LATSU}	$\overline{\text{LAT}} \downarrow$ to SCK \uparrow (write data 24th bit) setup time	10	—	ns	Write Data transferred ⁽⁴⁾
96	T _{LAT}	$\overline{\text{LAT}}$ high or low time	50	—	ns	
97	T _{HVCSU}	HVC \uparrow to SCK \uparrow (1st data bit) (HVC setup time)	0	—	ns	High-Voltage Commands ⁽¹⁾
98	T _{HVCHD}	SCK \downarrow (last bit of command (8th or 24th bit)) to HVC \downarrow (HVC hold time)	25	—	ns	High-Voltage Commands ⁽¹⁾

Note 1 This parameter is ensured by design.

Note 4 The transition of the LAT signal must occur 10 ns before the rising edge of the 24th SCK signal (Spec 94) or the current register data value may not be transferred to the output latch (VOUT) before the register is overwritten with the new value.

Timing Table Notes:

1. This parameter is ensured by design.
2. This parameter ensured by characterization.
3. Within 1/2 LSB of final value when code changes from 1/4 to 3/4 of FSR. (Example: 400h to C00h in 12-bit device).
4. The transition of the LAT signal must occur 10 ns before the rising edge of the 24th SCK signal (Spec 94) or the current register data value may not be transferred to the output latch (V_{OUT}) before the register is overwritten with the new value.

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Temperature Specifications

Electrical Specifications: Unless otherwise indicated, $V_{DD} = +2.7V$ to $+5.5V$, $V_{SS} = GND$.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Temperature Ranges						
Specified Temperature Range	T_A	-40	—	+125	°C	
Operating Temperature Range	T_A	-40	—	+125	°C	Note 1
Storage Temperature Range	T_A	-65	—	+150	°C	
Thermal Package Resistances						
Thermal Resistance, 10LD-MSOP	θ_{JA}	—	202	—	°C/W	

Note 1: The MCP48FEBXX devices operate over this extended temperature range, but with reduced performance. Operation in this range must not cause T_J to exceed the Maximum Junction Temperature of $+150^\circ\text{C}$.

2.0 TYPICAL PERFORMANCE CURVES

Note: The device Performance Curves are available in a separate document. This is done to keep the file size of this PDF document less than the 10 MB file attachment limit of many mail servers.
The MCP48FXBXX Performance Curves document is literature number **DS20005440**, and can be found on the Microchip website. Look on the MCP48FEBXX product page under “Documentation and Software”, in the Data Sheets category.